

<b>Notice of References Cited</b>	Application/Control No. 10/790,782	Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner Charles Ehne	Art Unit 2113	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0052130	12-2001	Yap et al.	725/90
*	B	US-6,400,728	06-2002	Ott, Stefan	370/465
*	C	US-6,654,901	11-2003	Nakai et al.	714/1
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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